Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	2	"5585738".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/29 12:30
L2	3	"5912555".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/29 12:31
L3	2	"5640101".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/29 12:32
L4	2	"6140828".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/29 12:32
L5	3	"6262570".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/29 12:32
L6	2	"6850052".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/29 12:33
L7	40	(thermal adj2 deformation) and probe adj card	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/29 13:01
L8	181561	(probe adj card)(displacement same(sens$4 or measur$4 or detect$4 or monitor$4))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/29 13:04
L9	1994	8 and (wafer and chuck)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/29 13:05

| L10 | 363 | 9 and (plate with probe) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/03/29 13:05 |